Notice of References Cited	Application/Control No. 10/572,566	Applicant(s)/Patent Under Reexamination DUPLAN ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	In Suk Bullock	1797		
U.S. PATENT DOCUMENTS				

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,093,867	07-2000	Ladwig et al.	585/648
	В	US-			
	U	US-			
	ם	US-			
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	F	US-			
	O	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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